

<b>Notice of References Cited</b>	Application/Control No. 10/651,302		Applicant(s)/Patent Under Reexamination FRICK ET AL.	
	Examiner John A. Tweel, Jr.		Art Unit 2636	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0082859	06-2002	Lancos et al.	705/1
*	B	US-6,078,928	06-2000	Schnase et al.	707/104.1
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	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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